

**Notice of References Cited**

Application/Control No.

09/281,430

Applicant(s)/Patent Under  
Reexamination  
PARIKH ET AL.

Examiner

Todd D Ware

Art Unit

1615

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	N	WO 96/34515	11-1996	WIPO	Sime et al	----
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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